Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/047,474	FRANK ET AL.	
Examiner	Art Unit	
F. Lin Khoo	2664	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	241	7/25/2005	FLK
370	242	7/25/2005	FLK
370	245	7/25/2005	FLK
370	250	7/25/2005	FLK
370	503	7/25/2005	FLK
370	509	7/25/2005	FLK
370	514	7/25/2005	FLK
370	522	7/25/2005	FLK

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